

To our customers,

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## Old Company Name in Catalogs and Other Documents

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Renesas Electronics website: <http://www.renesas.com>

April 1<sup>st</sup>, 2010  
Renesas Electronics Corporation

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April 1, 2003

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# HM62W8512BI Series

4 M SRAM (512-kword  $\times$  8-bit)



ADE-203-1086A (Z)

Rev. 1.0

Jul. 13, 1999

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## Description

The Hitachi HM62W8512BI is a 4-Mbit static RAM organized 512-kword  $\times$  8-bit. HM62W8512BI Series has realized higher density, higher performance and low power consumption by employing Hi-CMOS process technology. The HM62W8512BI Series offers low power standby power dissipation; therefore, it is suitable for battery backup systems. It is packaged in standard 32-pin TSOP II.

## Features

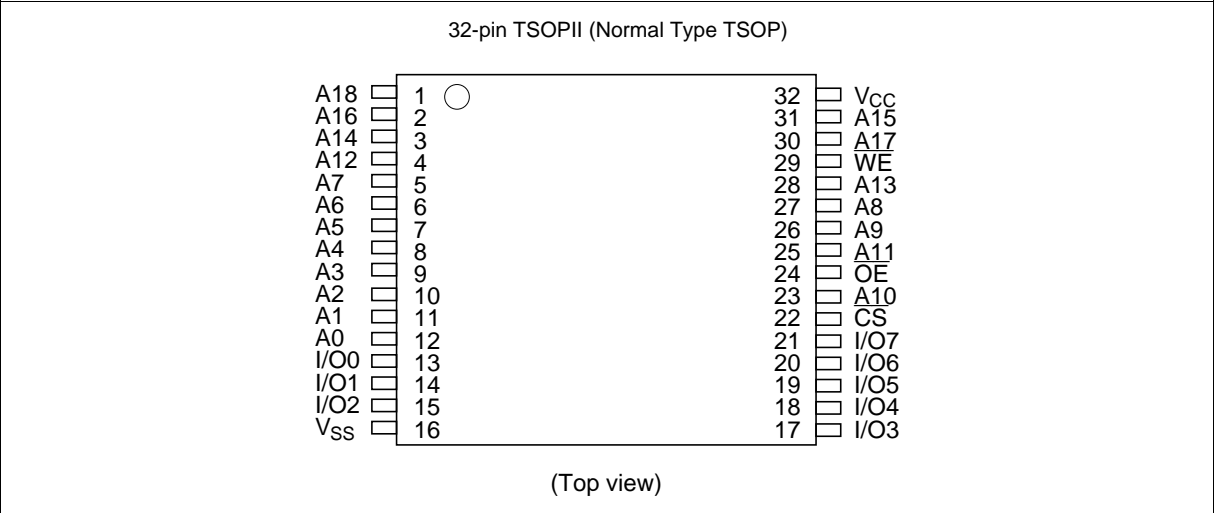
- Single 3.3 V supply: 3.3 V  $\pm$  0.3V
- Access time: 70/85 ns (max)
- Power dissipation
  - Active: 16.5 mW/MHz (typ)
  - Standby: 3.3  $\mu$ W (typ)
- Completely static memory. No clock or timing strobe required
- Equal access and cycle times
- Common data input and output: Three state output
- Directly LV-TTL compatible: All inputs and outputs
- Battery backup operation
- Operating temperature:  $-40$  to  $+85^{\circ}\text{C}$

## Ordering Information

Type No.	Access time	Package
HM62W8512BLTTI-7	70 ns	400-mil 32-pin plastic TSOP II (TTP-32D)
HM62W8512BLTTI-8	85 ns	

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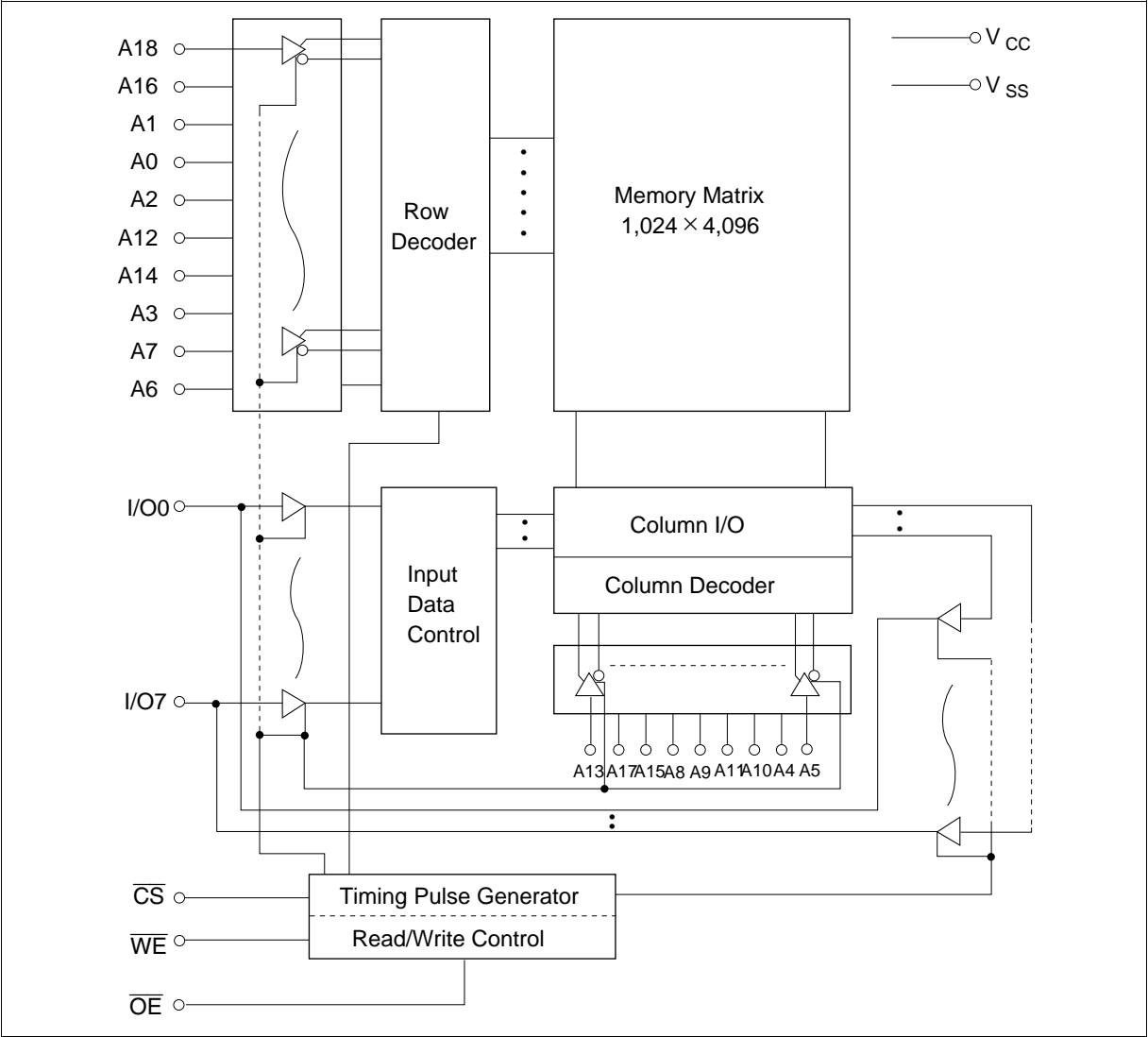
Pin Arrangement



Pin Description

Pin name	Function
A0 to A18	Address input
I/O0 to I/O7	Data input/output
CS	Chip select
OE	Output enable
WE	Write enable
V <sub>cc</sub>	Power supply
V <sub>ss</sub>	Ground

Block Diagram



## Function Table

$\overline{WE}$	$\overline{CS}$	$\overline{OE}$	Mode	$V_{CC}$ current	Dout pin	Ref. cycle
×	H	×	Not selected	$I_{SB}, I_{SB1}$	High-Z	—
H	L	H	Output disable	$I_{CC}$	High-Z	—
H	L	L	Read	$I_{CC}$	Dout	Read cycle
L	L	H	Write	$I_{CC}$	Din	Write cycle (1)
L	L	L	Write	$I_{CC}$	Din	Write cycle (2)

Note: ×: H or L

## Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Power supply voltage	$V_{CC}$	−0.5 to +4.6	V
Voltage on any pin relative to $V_{SS}$	$V_T$	−0.5* <sup>1</sup> to $V_{CC} + 0.5$ * <sup>2</sup>	V
Power dissipation	$P_T$	1.0	W
Operating temperature	$T_{opr}$	−40 to +85	°C
Storage temperature	$T_{stg}$	−55 to +125	°C
Storage temperature under bias	$T_{bias}$	−40 to +85	°C

Notes: 1. −3.0 V for pulse half-width ≤ 30 ns

2. Maximum voltage is 4.6 V

## Recommended DC Operating Conditions ( $T_a = -40$ to +85°C)

Parameter	Symbol	Min	Typ	Max	Unit
Supply voltage	$V_{CC}$	3.0	3.3	3.6	V
	$V_{SS}$	0	0	0	V
Input high voltage	$V_{IH}$	2.4	—	$V_{CC} + 0.3$	V
Input low voltage	$V_{IL}$	−0.3* <sup>1</sup>	—	0.6	V

Note: 1. −3.0 V for pulse half-width ≤ 30 ns



**DC Characteristics** ( $T_a = -40$  to  $+85^{\circ}\text{C}$ ,  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ ,  $V_{SS} = 0\text{ V}$ )

Parameter	Symbol	Min	Typ* <sup>1</sup>	Max	Unit	Test conditions
Input leakage current	$ I_{LI} $	—	—	1	$\mu\text{A}$	$V_{in} = V_{SS}$ to $V_{CC}$
Output leakage current	$ I_{LO} $	—	—	1	$\mu\text{A}$	$\overline{CS} = V_{IH}$ or $\overline{OE} = V_{IH}$ or $\overline{WE} = V_{IL}$ , $V_{I/O} = V_{SS}$ to $V_{CC}$
Operating power supply current: DC	$I_{CC}$	—	—	10	mA	$\overline{CS} = V_{IL}$ , others = $V_{IH}/V_{IL}$ , $I_{I/O} = 0\text{ mA}$
Operating power supply current	$I_{CC1}$	—	—	45	mA	Min cycle, duty = 100% $\overline{CS} = V_{IL}$ , others = $V_{IH}/V_{IL}$ $I_{I/O} = 0\text{ mA}$
Operating power supply current	$I_{CC2}$	—	5	10	mA	Cycle time = $1\text{ }\mu\text{s}$ , duty = 100% $I_{I/O} = 0\text{ mA}$ , $\overline{CS} \leq 0.2\text{ V}$ $V_{IH} \geq V_{CC} - 0.2\text{ V}$ , $V_{IL} \leq 0.2\text{ V}$
Standby power supply current: DC	$I_{SB}$	—	0.1	0.3	mA	$\overline{CS} = V_{IH}$
Standby power supply current (1): DC	$I_{SB1}$	—	$1^{*2}$	$40^{*2}$	$\mu\text{A}$	$V_{in} \geq 0\text{ V}$ , $\overline{CS} \geq V_{CC} - 0.2\text{ V}$
Output low voltage	$V_{OL}$	—	—	0.4	V	$I_{OL} = 2.0\text{ mA}$
		—	—	0.2	V	$I_{OL} = 100\text{ }\mu\text{A}$
Output high voltage	$V_{OH}$	$V_{CC} - 0.2$	—	—	V	$I_{OH} = -100\text{ }\mu\text{A}$
		2.4	—	—	V	$I_{OH} = -2.0\text{ mA}$

Note: 1. Typical values are at  $V_{CC} = 3.3\text{ V}$ ,  $T_a = +25^{\circ}\text{C}$  and specified loading, and not guaranteed.  
2. This characteristics is guaranteed only for L-version.

**Capacitance** ( $T_a = +25^{\circ}\text{C}$ ,  $f = 1\text{ MHz}$ )

Parameter	Symbol	Typ	Max	Unit	Test conditions
Input capacitance* <sup>1</sup>	$C_{in}$	—	8	pF	$V_{in} = 0\text{ V}$
Input/output capacitance* <sup>1</sup>	$C_{I/O}$	—	10	pF	$V_{I/O} = 0\text{ V}$

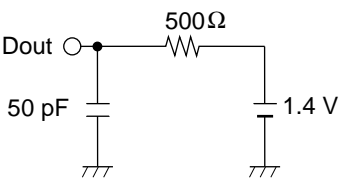
Note: 1. This parameter is sampled and not 100% tested.

# HM62W8512BI Series

**AC Characteristics** ( $T_a = -40$  to  $+85^{\circ}\text{C}$ ,  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ , unless otherwise noted.)

## Test Conditions

- Input pulse levels: 0.4 V to 2.4 V
- Input rise and fall time: 5 ns
- Input timing reference levels: 1.4 V
- Output timing reference level: 0.8 V/2.0 V
- Output load (Including scope & jig)



## Read Cycle

		HM62W8512BI					
		-7		-8			
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes
Read cycle time	t <sub>RC</sub>	70	—	85	—	ns	
Address access time	t <sub>AA</sub>	—	70	—	85	ns	
Chip select access time	t <sub>CO</sub>	—	70	—	85	ns	
Output enable to output valid	t <sub>OE</sub>	—	35	—	45	ns	
Chip selection to output in low-Z	t <sub>LZ</sub>	10	—	10	—	ns	2
Output enable to output in low-Z	t <sub>OLZ</sub>	5	—	5	—	ns	2
Chip deselection to output in high-Z	t <sub>HZ</sub>	0	30	0	35	ns	1, 2
Output disable to output in high-Z	t <sub>OHZ</sub>	0	30	0	35	ns	1, 2
Output hold from address change	t <sub>OH</sub>	10	—	10	—	ns	

## Write Cycle

		HM62W8512BI					
		-7		-8			
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes
Write cycle time	t <sub>WC</sub>	70	—	85	—	ns	
Chip selection to end of write	t <sub>CW</sub>	60	—	75	—	ns	4
Address setup time	t <sub>AS</sub>	0	—	0	—	ns	5
Address valid to end of write	t <sub>AW</sub>	60	—	75	—	ns	
Write pulse width	t <sub>WP</sub>	50	—	55	—	ns	3, 12
Write recovery time	t <sub>WR</sub>	0	—	0	—	ns	6
$\overline{WE}$ to output in high-Z	t <sub>WHZ</sub>	0	30	0	35	ns	1, 2, 7
Data to write time overlap	t <sub>DW</sub>	30	—	35	—	ns	
Data hold from write time	t <sub>DH</sub>	0	—	0	—	ns	
Output active from output in high-Z	t <sub>OW</sub>	5	—	5	—	ns	2
Output disable to output in high-Z	t <sub>OHZ</sub>	0	30	0	35	ns	1, 2, 7

Notes: 1.  $t_{HZ}$ ,  $t_{OHZ}$  and  $t_{WHZ}$  are defined as the time at which the outputs achieve the open circuit conditions and are not referred to output voltage levels.

2. This parameter is sampled and not 100% tested.

3. A write occurs during the overlap ( $t_{WP}$ ) of a low  $\overline{CS}$  and a low  $\overline{WE}$ . A write begins at the later transition of  $\overline{CS}$  going low or  $\overline{WE}$  going low. A write ends at the earlier transition of  $\overline{CS}$  going high or  $\overline{WE}$  going high.  $t_{WP}$  is measured from the beginning of write to the end of write.

4.  $t_{CW}$  is measured from  $\overline{CS}$  going low to the end of write.

5.  $t_{AS}$  is measured from the address valid to the beginning of write.

6.  $t_{WR}$  is measured from the earlier of  $\overline{WE}$  or  $\overline{CS}$  going high to the end of write cycle.

7. During this period, I/O pins are in the output state so that the input signals of the opposite phase to the outputs must not be applied.

8. If the  $\overline{CS}$  low transition occurs simultaneously with the  $\overline{WE}$  low transition or after the  $\overline{WE}$  transition, the output remain in a high impedance state.

9. Dout is the same phase of the write data of this write cycle.

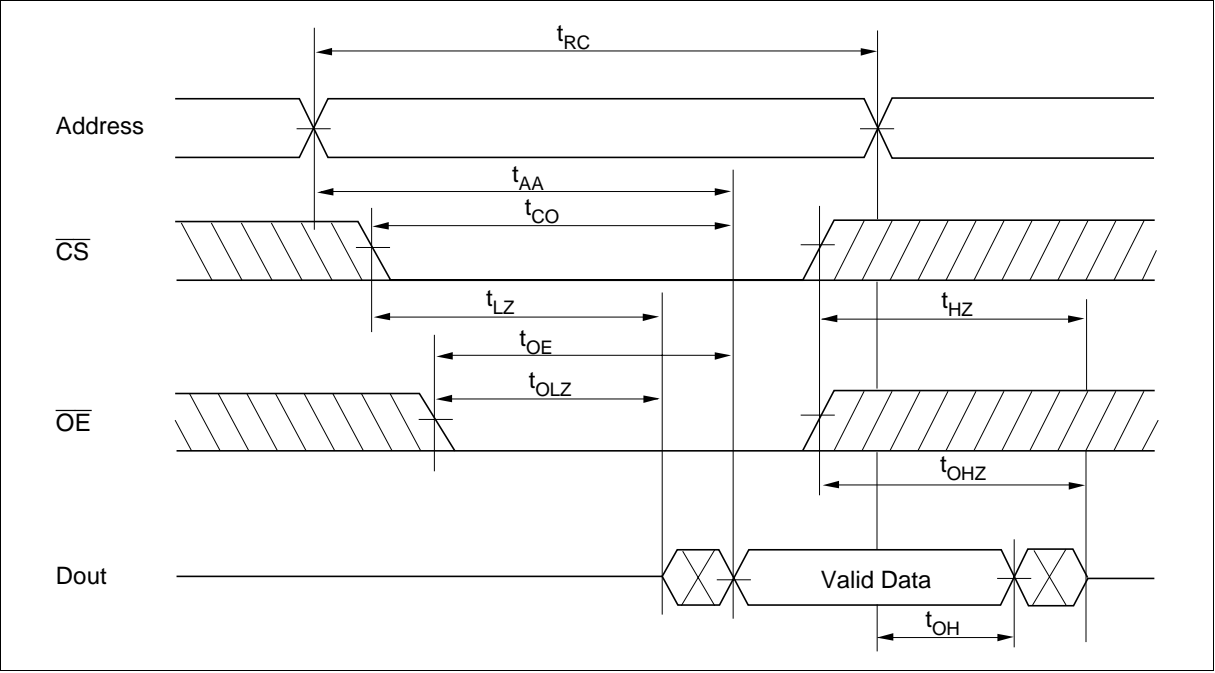
10. Dout is the read data of next address.

11. If  $\overline{CS}$  is low during this period, I/O pins are in the output state. Therefore, the input signals of the opposite phase to the outputs must not be applied to them.

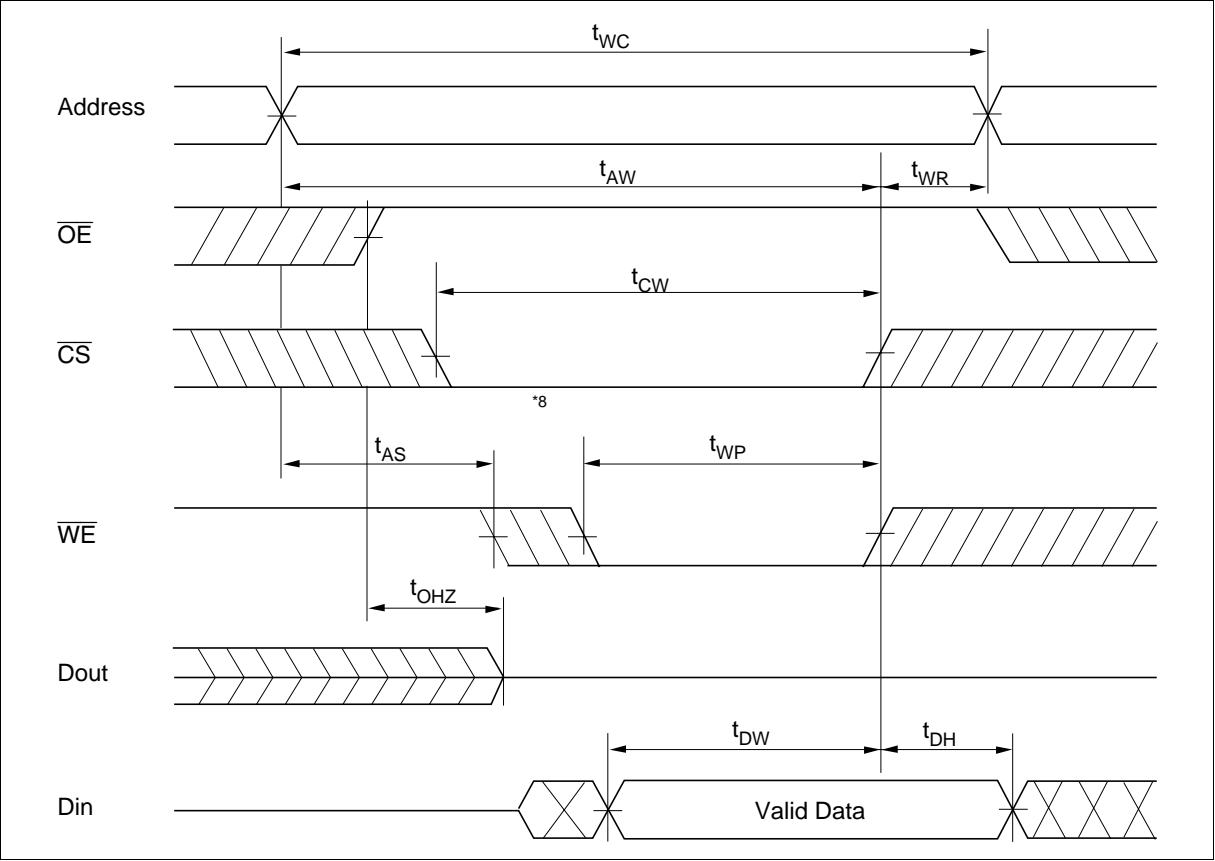
12. In the write cycle with  $\overline{OE}$  low fixed,  $t_{WP}$  must satisfy the following equation to avoid a problem of data bus contention.  $t_{WP} \geq t_{DW} \text{ min} + t_{WHZ} \text{ max}$

Timing Waveforms

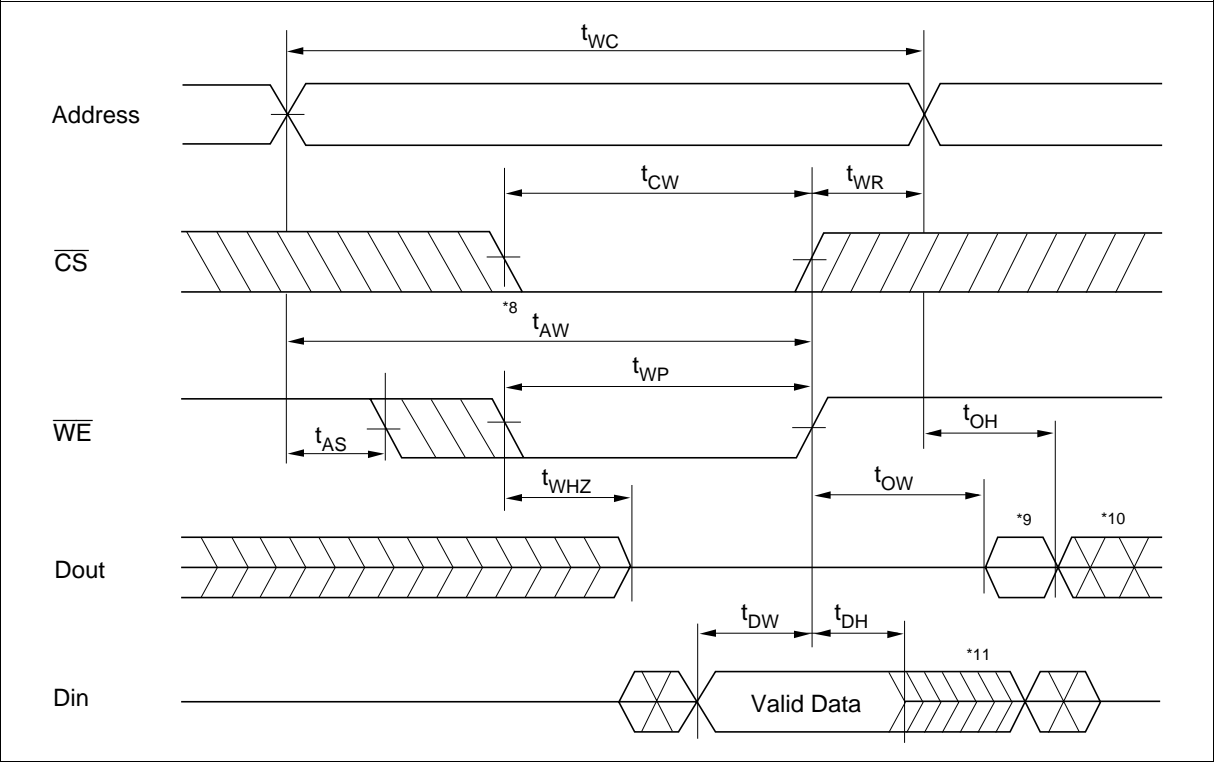
Read Timing Waveform ( $\overline{WE} = V_{IH}$ )



Write Timing Waveform (1) ( $\overline{\text{OE}}$  Clock)



Write Timing Waveform (2) ( $\overline{\text{OE}}$  Low Fixed)



## Low $V_{CC}$ Data Retention Characteristics ( $T_a = -40$ to $+85^\circ\text{C}$ )

Parameter	Symbol	Min	Typ	Max	Unit	Test conditions* <sup>2</sup>
$V_{CC}$ for data retention	$V_{DR}$	2	—	—	V	$\overline{CS} \geq V_{CC} - 0.2 \text{ V}$ , $V_{in} \geq 0 \text{ V}$
Data retention current	$I_{CCDR}$	—	0.8* <sup>3</sup>	20* <sup>1</sup>	$\mu\text{A}$	$V_{CC} = 3.0 \text{ V}$ , $V_{in} \geq 0 \text{ V}$ $\overline{CS} \geq V_{CC} - 0.2 \text{ V}$
Chip deselect to data retention time	$t_{CDR}$	0	—	—	ns	See retention waveform
Operation recovery time	$t_R$	$t_{RC}$ * <sup>4</sup>	—	—	ns	

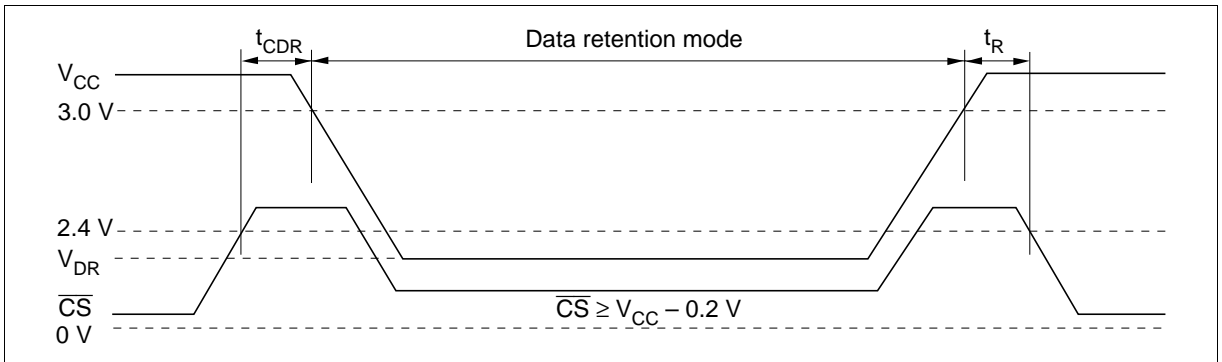
Notes: 1. For L-version and 10  $\mu\text{A}$  (max.) at  $T_a = -40$  to  $+40^\circ\text{C}$ .

2.  $\overline{CS}$  controls address buffer,  $\overline{WE}$  buffer,  $\overline{OE}$  buffer, and  $D_{in}$  buffer. In data retention mode,  $V_{in}$  levels (address,  $\overline{WE}$ ,  $\overline{OE}$ , I/O) can be in the high impedance state.

3. Typical values are at  $V_{CC} = 3.0 \text{ V}$ ,  $T_a = +25^\circ\text{C}$  and specified loading, and not guaranteed.

4.  $t_{RC}$  = read cycle time.

## Low $V_{CC}$ Data Retention Timing Waveform ( $\overline{CS}$ Controlled)

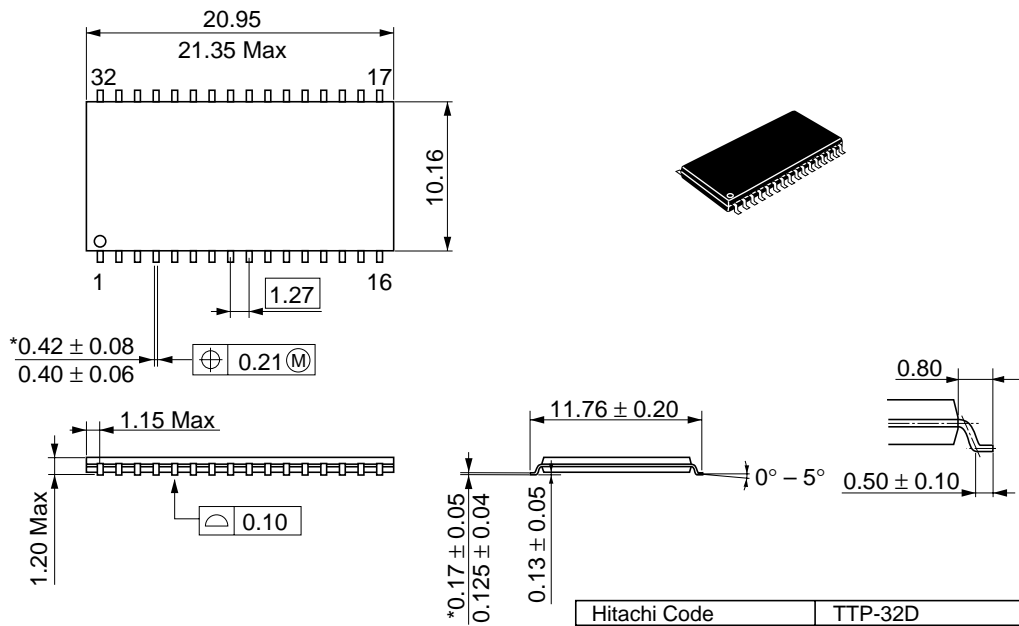


# HM62W8512BI Series

## Package Dimensions

### HM62W8512BLTTI Series (TTP-32D)

Unit: mm



\*Dimension including the plating thickness  
Base material dimension

Hitachi Code	TTP-32D
JEDEC	Conforms
EIAJ	—
Weight (reference value)	0.51 g



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